

June 2009

FDP040N06

N-Channel PowerTrench[®] MOSFET 60V, 168A, $4.0m\Omega$

Features

- $R_{DS(on)} = 3.2 m\Omega$ (Typ.) @ $V_{GS} = 10 V$, $I_D = 75 A$
- · Fast Switching Speed
- · Low Gate Charge
- \bullet High Performance Trench Technology for Extremely Low $R_{\mbox{DS(on)}}$
- · High Power and Current Handling Capability
- RoHS Compliant



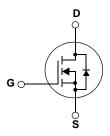
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

• DC to DC convertors / Synchronous Rectification





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter	Parameter		Units
V _{DSS}	Drain to Source Voltage			60	V
V _{GSS}	Gate to Source Voltage	Source Voltage			V
		-Continuous (T _C = 25°C, Silicion	Limited)	168*	
I _D	Drain Current -Continuous ($T_C = 100^{\circ}C$,		n Limited)	118*	Α
		-Continuous (T _C = 25°C, Package	e Limited)	120	
I _{DM}	Drain Current	- Pulsed	- Pulsed (Note 1)		Α
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	872	mJ
dv/dt	Peak Diode Recovery dv/d	ode Recovery dv/dt (Note 3)		7.0	V/ns
n	Danna Diaginatian	$(T_C = 25^{\circ}C)$		231	W
P_{D}	Power Dissipation	- Derate above 25°C		1.54	W/°C
T _J , T _{STG}	Operating and Storage Te	mperature Range		-55 to +175	°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

*Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

Thermal Characteristics

Symbol	Parameter Ratings			
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.65	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient 62		C/VV	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP038N06	FDP038N06	TO-220	Tube	-	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	eteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A$, $V_{GS} = 0V$, $T_C = 25^{\circ}C$	60	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.04	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V$	-	-	1	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V, T_{C} = 150^{\circ}C$	-	-	500	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	3.5	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 75A$	-	3.2	4.0	mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_D = 75A$ (Note 4)	-	169	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	25// // 27/	-	6190	8235	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ 	-	900	1195	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/12	-	385	580	pF
$Q_{g(tot)}$	Total Gate Charge at 10V	V _{DS} = 48V, I _D = 75A	-	102	133	nC
Q_{gs}	Gate to Source Gate Charge	V _{GS} = 10V	-	32	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	(Note 4, 5)	-	32	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	30	70	ns
t _r		$V_{DD} = 30V, I_{D} = 75A$	-	40	90	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 4.7\Omega$	-	55	120	ns
t _f	Turn-Off Fall Time	(Note 4, 5)	-	24	58	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	-	168	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	672	Α
V _{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 75A$		-	-	1.3	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 75A		-	41	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	47	-	nC

- Notes: 1: Repetitive Rating: Pulse width limited by maximum junction temperature 2: L = 0.31 mH, I_{AS} = 75A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3: I_{SD} ≤ 75A, I_{OD} = 0.00A/ μ_{B} , V_{DD} ≤ BV/ D_{SS} , Starting T_{J} = 25°C 4: Pulse Test: Pulse width ≤ 300 μ_{B} , Duty Cycle ≤ 2% 5: Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

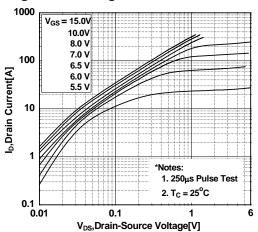


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

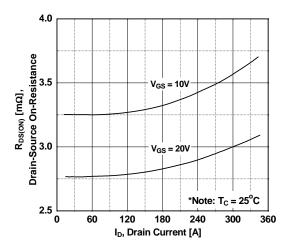


Figure 5. Capacitance Characteristics

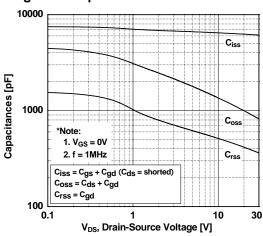


Figure 2. Transfer Characteristics

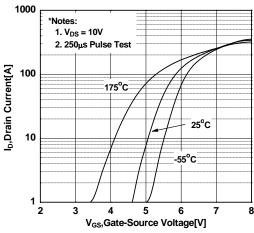


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

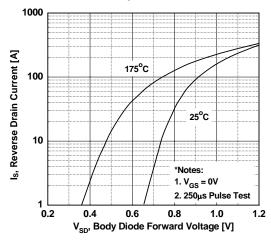
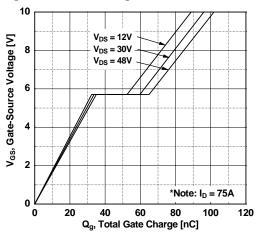


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

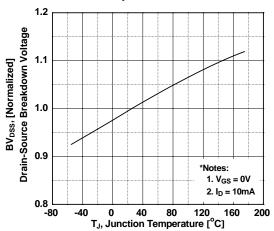


Figure 8. On-Resistance Variation vs. Temperature

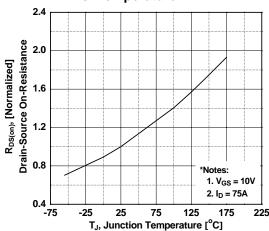


Figure 9. Maximum Safe Operating Area

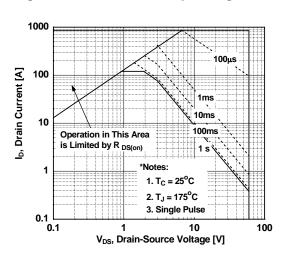


Figure 10. Maximum Drain Current vs. Case Temperature

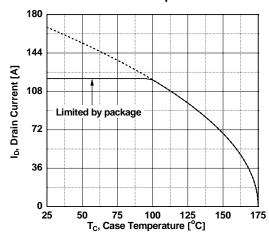
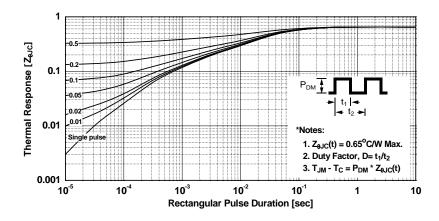
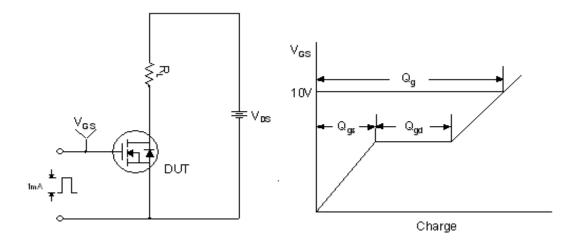


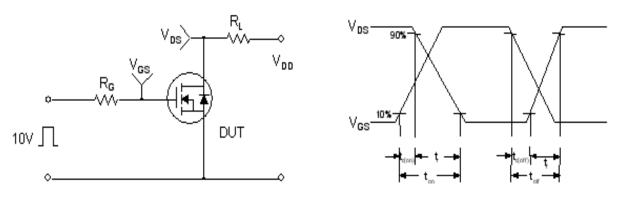
Figure 11. Transient Thermal Response Curve



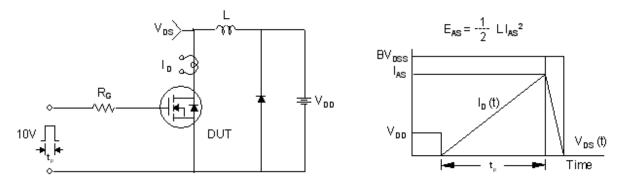
Gate Charge Test Circuit & Waveform



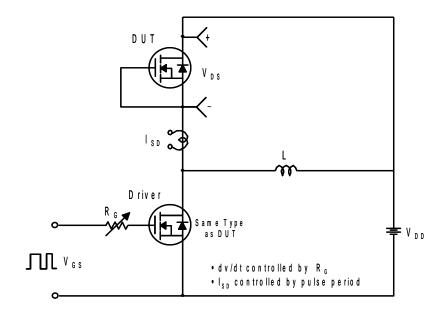
Resistive Switching Test Circuit & Waveforms

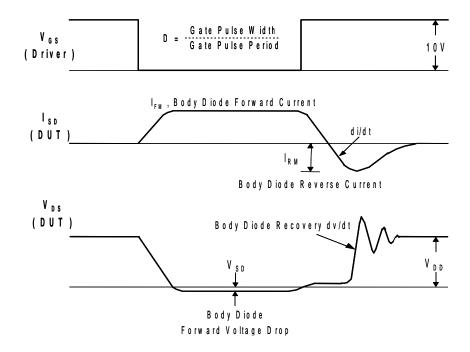


Unclamped Inductive Switching Test Circuit & Waveforms



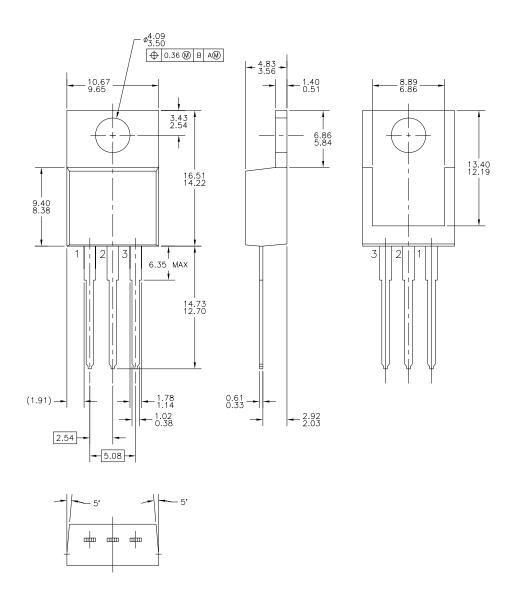
Peak Diode Recovery dv/dt Test Circuit & Waveforms





Mechanical Dimensions

TO-220







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